

# N-Channel Enhancement Mode MOSFET

## 1. Product Information

### Features

- VD-MOSFET technology
- Improve switching performance

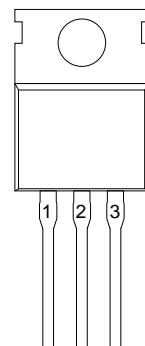
### Pin Description

| Pin | Description |
|-----|-------------|
| 1   | Gate(G)     |
| 2   | Drain(D)    |
| 3   | Source(S)   |

### Applications

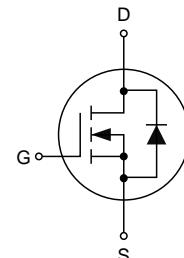
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

### Simplified Outline



Top View  
TO-220

### Symbol



### Quick reference

$V_{DS} = 200 \text{ V}$   
 $I_D = 18 \text{ A}$   
 $R_{DS(\text{ON})} \leq 150 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$  (Type:120 mΩ)

### Package Marking and Ordering Information

| Product Name | Package | Marking            | Reel size | Tape width | Quantity (pcs) |
|--------------|---------|--------------------|-----------|------------|----------------|
| KJ18N20C     | TO-220  | KJ18N20C<br>XXXXXX | N/A       | N/A        | 1000           |

## 2. Absolute Maximum Ratings ( $T_C=25^\circ\text{C}$ unless otherwise noted)

| Symbol          | Parameter  | Values   | Unit |
|-----------------|--|----------|------|
| $V_{DS}$        | Drain-Source Voltage, $V_{GS}=0\text{V}$         | 200      | V    |
| $V_{GS}$        | Gate-Source Voltage                              | $\pm 20$ | V    |
| $I_D$           | Continuous Drain Current                         | 18       | A    |
| $I_{DM}$        | Pulsed Drain Current <sup>1</sup>                | 72       | A    |
| $E_{AS}$        | Single Pulse Avalanche Energy <sup>2</sup>       | 340      | mJ   |
| $P_D$           | Power Dissipation @ $T_C=25^\circ\text{C}$       | 104      | W    |
| $T_J, T_{STG}$  | Operating Junction and Storage Temperature Range | -55~150  | °C   |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient          | 62.5     | °C/W |
| $R_{\theta JC}$ | Thermal Resistance Junction to Case              | 1.2      | °C/W |

### 3. Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)

| Symbol                     | Parameter                               | Test Conditions  | Min. | Typ. | Max.      | Unit             |
|----------------------------|---|--|------|------|-----------|------------------|
| $\text{BV}_{\text{DSS}}$   | Drain-Source Breakdown Voltage          | $V_{\text{GS}}=0 \text{ V}, I_{\text{D}}=250 \mu\text{A}$                            | 200  | 220  | -         | V                |
| $I_{\text{GSS}}$           | Gate-body Leakage current               | $V_{\text{DS}}=0 \text{ V}, V_{\text{GS}}=\pm 20 \text{ V}$                          | -    | -    | $\pm 100$ | nA               |
| $I_{\text{DSS}}$           | Zero Gate Voltage Drain Current         | $V_{\text{DS}}=200 \text{ V}, V_{\text{GS}}=0 \text{ V}, T_J=25^\circ\text{C}$       | -    | -    | 5         | $\mu\text{A}$    |
|                            |   | $V_{\text{DS}}=160 \text{ V}, V_{\text{GS}}=0 \text{ V}, T_J=125^\circ\text{C}$      | -    | -    | 100       |                  |
| $V_{\text{GS}(\text{th})}$ | Gate-Threshold Voltage                  | $V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250 \mu\text{A}$                          | 2    | 3    | 4         | V                |
| $R_{\text{DS}(\text{on})}$ | Drain-Source on-Resistance <sup>3</sup> | $V_{\text{GS}}=10 \text{ V}, I_{\text{D}}=9 \text{ A}$                               | -    | 120  | 150       | $\text{m}\Omega$ |
| $C_{\text{iss}}$           | Input Capacitance                       | $V_{\text{GS}}=0 \text{ V}, V_{\text{DS}}=25 \text{ V}, f=1 \text{ MHz}$             | -    | 1318 | -         | $\text{pF}$      |
| $C_{\text{oss}}$           | Output Capacitance                      |  | -    | 180  | -         |                  |
| $C_{\text{rss}}$           | Reverse Transfer Capacitance            |  | -    | 75   | -         |                  |
| $Q_g$                      | Total Gate Charge                       | $V_{\text{DS}}=160 \text{ V}, V_{\text{GS}}=10 \text{ V}, I_{\text{D}}=18 \text{ A}$ | -    | 41   | -         | $\text{nC}$      |
| $Q_{\text{gs}}$            | Gate-Source Charge                      |  | -    | 5.5  | -         |                  |
| $Q_{\text{gd}}$            | Gate-Drain Charge                       |  | -    | 19.5 | -         |                  |
| $t_{\text{d}(\text{on})}$  | Turn-on Delay Time                      | $V_{\text{DD}}=100 \text{ V}, R_{\text{G}}=25 \Omega, I_{\text{D}}=18 \text{ A}$     | -    | 24   | -         | $\text{ns}$      |
| $t_r$                      | Turn-on Rise Time                       |  | -    | 45   | -         |                  |
| $t_{\text{d}(\text{off})}$ | Turn-off Delay Time                     |  | -    | 101  | -         |                  |
| $t_f$                      | Turn-off Fall Time                      |  | -    | 95   | -         |                  |
| $I_s$                      | Continuous Source Current               | $T_c=25^\circ\text{C}$   | -    | -    | 18        | A                |
| $I_{\text{SM}}$            | Pulsed Diode Forward Current            |  | -    | -    | 72        | A                |
| $V_{\text{SD}}$            | Diode Forward Voltage                   | $T_J=25^\circ\text{C}, I_{\text{SD}}=18 \text{ A}, V_{\text{GS}}=0 \text{ V}$        | -    | -    | 1.4       | V                |
| $t_{\text{rr}}$            | Body Diode Reverse Recovery Time        | $V_{\text{GS}}=0 \text{ V}, I_s=18 \text{ A}, dI/dt=100 \text{ A}/\mu\text{s}$       | -    | 230  | -         | ns               |
| $Q_{\text{rr}}$            | Body Diode Reverse Recovery Charge      |  | -    | 1.8  | -         | $\mu\text{C}$    |

Notes:

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2 OZ copper.
2. The EAS data shows Max. rating.  $I_{\text{AS}}=15 \text{ A}, V_{\text{DD}}=50 \text{ V}, R_{\text{G}}=25 \Omega$ , Starting  $T_J=25^\circ\text{C}$ .
3. The test condition is Pulse Test: Pulse width  $\leq 300 \mu\text{s}$ , Duty Cycle  $\leq 1\%$ .
4. The power dissipation is limited by  $150^\circ\text{C}$  junction temperature.
5. The data is theoretically the same as  $I_D$  and  $I_{\text{DM}}$ , in real applications, should be limited by total power dissipation.

## 4. Typical Characteristics

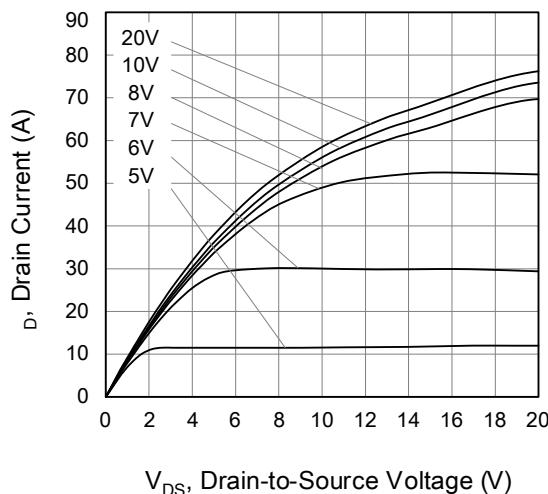


Figure 1: Output Characteristics ( $T_J=25^\circ\text{C}$ )

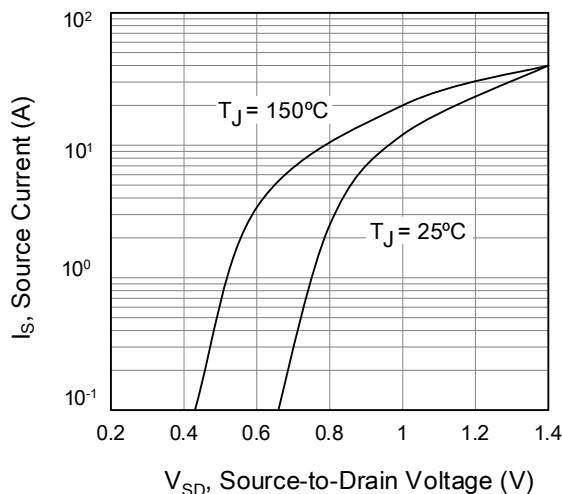


Figure 2: Body Diode Forward Voltage

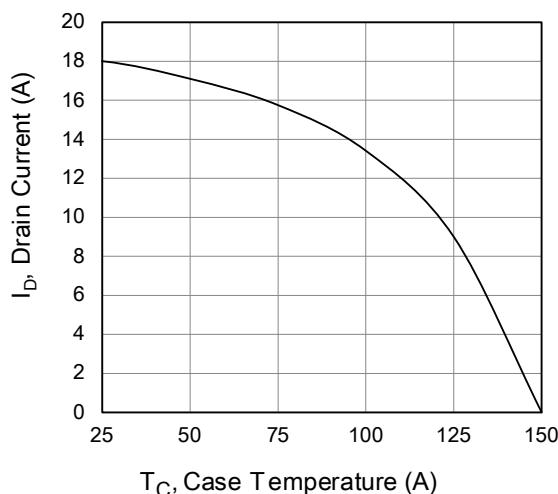


Figure 3: Drain Current vs. Temperature

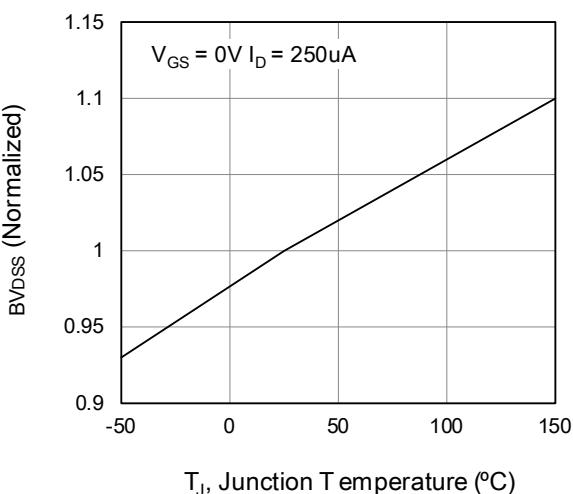


Figure 4: Body Diode Characteristics

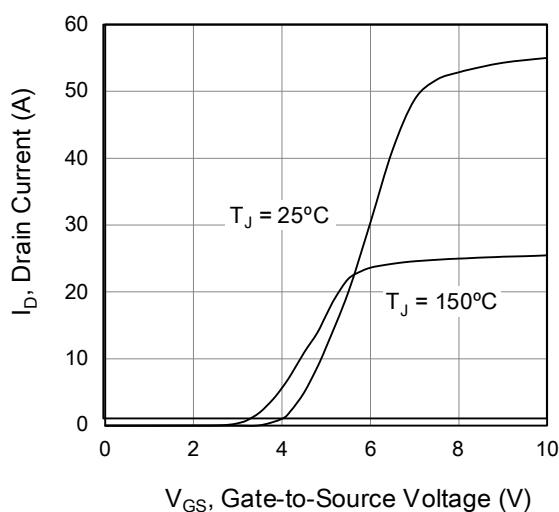


Figure 5: Transfer Characteristics

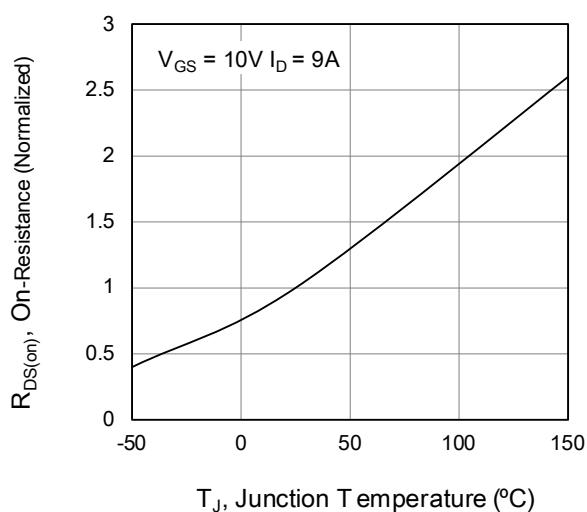
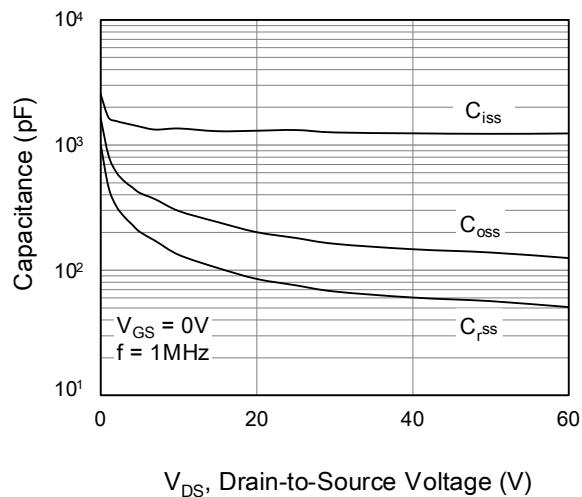
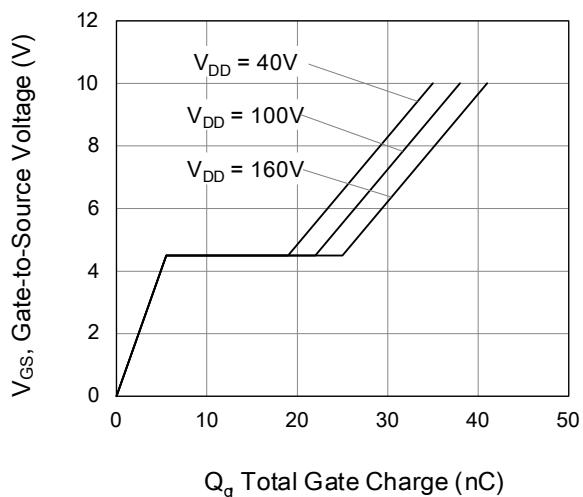


Figure 6: On-resistance vs. Temperature

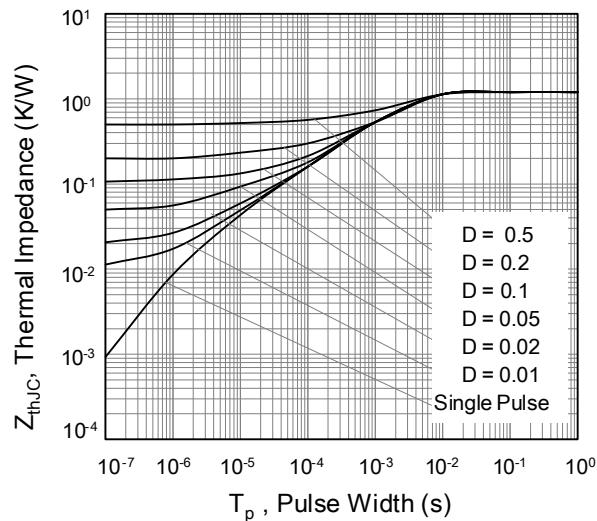
## 4. Typical Characteristics (cont.)



**Figure 7: Capacitance**



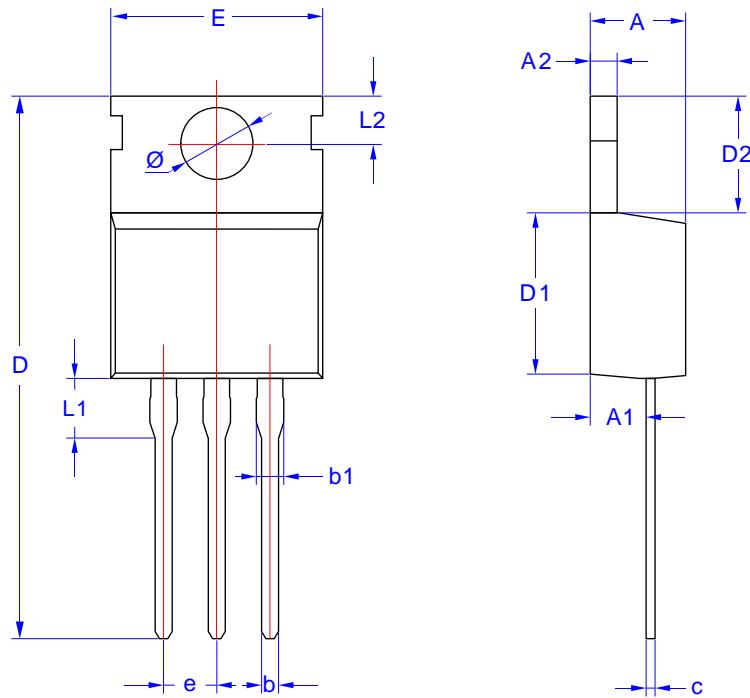
**Figure 8: Gate Charge**



**Figure 9: Transient Thermal Impedance**

## 5. Package Mechanical Data

TO-220 Package



| Symbol | Dimensions in Millimeters |       |
|--------|---------------------------|-------|
|        | MIN                       | MAX   |
| A      | 4.24                      | 4.70  |
| A1     | 2.20                      | 3.00  |
| A2     | 1.15                      | 1.40  |
| b      | 0.70                      | 0.95  |
| b1     | 1.14                      | 1.70  |
| c      | 0.40                      | 0.60  |
| D      | 28.0                      | 29.8  |
| D1     | 8.80                      | 9.90  |
| D2     | 6.25                      | 6.90  |
| E      | 9.70                      | 10.50 |
| L1     | 3.80                      |       |
| L2     | 2.40                      | 3.00  |
| e      | 2.54 BSC                  |       |
| $\Phi$ | 3.60                      |       |